

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/506,770	IIZUKA, TAKASHI	
Examiner	Art Unit	
Alfred Joseph Wuiciak III	3632	

	SEAR	SEARCHED		
Class	Subclass	Date	Examiner	
248	447	1/31/2006	AJW	
248	448	1/31/2006	AJW	
248	451	1/31/2006	AJW	
248	458	1/31/2006	AJW	
248	460	1/31/2006	WLA	
248	444.1	1/31/2006	WLA	
248	444	1/31/2006	AJW	
248	346.03	1/31/2006	AJW	
248	346.06	1/31/2006	AJW	
248	346.07	1/31/2006	AJW	

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
248	all subs	2/1/2006	AJW
	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Text Search	1/31/2006	WLA		
Allowance conference with Ramon Rameriz and Robert Olszewski	2/1/2006	AJW		
Interference Text Search	2/1/2006	AJW		
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